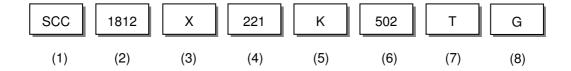


1. Scope

The SCC series X2, X1/Y2 safety capacitors are designed specifically for use in modem, facsimile, telephone and other electronic equipment.

These parts are compliant to EN60384-14, IEC60384-14, UL60384-14, CSA E60384-1 & CSA E60384-14. (This product compliant with the RoHS & HF and Pb free.)

2. Parts Number Code



(1)Product

Product Code	
SCC	Safety Approval of MLCC Product

(2)Chip Size

Code	Length×Width unit : mm(inch)	
1808	4.60× 2.00 (.18× .08)	
1812	4.60× 3.20 (.18× .12)	
2208	5.70× 2.00 (.22× .08)	
2211	5.70× 2.80 (.22× .11)	
2220	5.70× 5.00 (.22× .20)	
2825	7.10× 6.35 (.28× .25)	

(3) Temperature Characteristics

Code	Temperature	Temperature	Temperature		
	Characteristic	Range	Coefficient		
N	NPO	-55°C ~+125°C	30 ppm/°ℂ		
X	X7R	-55°C~+125°C	± 15%		

(5) Capacitance Tolerance

-		
Code	Tolerance	Nominal Capacitance
С	± 0.25 pF	Less Than 10 pF
D	± 0.50 pF	(Include 10 pF)
E	± 1.00 pF	_
J	± 5.00 %	More Than 10 pF
K	± 10.0 %	_
М	± 20.0 %	_
Q	+10%~+20%	_

(6) Class Level of Capacitors

Code	Class
202	X2
252	X2 (305Vac)
502	X1/Y2
602	X1/Y2 for
	SCC2208N,SCC2211N,SCC2220N Series

(4)Capacitance unit :pico farads(pF)

Code Nominal Capacitance (pF)					
5R0	5.0				
330	33.0				
221	220.0				
222	2,200.0				
103	10,000.0				

^{%.} If there is a decimal point, it shall be expressed by an English capital letter R

(7)Tapping

Code	Type
T	Tape & Reel
В	Bulk

(8) Special Requirement Code

Code	Type	
G	Pb free Type	

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3. Nominal Capacitance and Tolerance

3.1 Standard Combination of Nominal Capacitance and Tolerance

Class	Characteristic	Toler	ance	Nominal Capacitance
Class	NPO	Less Then 10 pF	C (± 0.25 pF)	0.5,1,1.5,2,2.5,3,3.5,4,4.5,5
I			D (± 0.50 pF)	5,6,7,8,9,10
			E (± 1.00 pF)	6,7,8,9,10
		More Than 10 pF	J (± 5.00 %)	E-24 series
			K (± 10.0 %)	
Class II	X7R	K (± 10.0 %),	M (± 20.0 %)	E-12 series

3.2 E series(standard Number)

Standard No.		Application Capacitance										
E- 3		1.	.0		2.2			4.7				
E- 6	1.	1.0 1.5 2.2		3.3		4.7		6.8				
E-12	1.0	1.2	1.5	1.8	2.2	2.7	3.3	3.9	4.7	5.6	6.8	8.2
E-24	1.0	1.2	1.5	1.8	2.2	2.7	3.3	3.9	4.7	5.6	6.8	8.2
	1.1	1.3	1.6	2.0	2.4	3.0	3.6	4.3	5.1	6.2	7.5	9.1

4. Operation Temperature Range

Class	Characteristic	Temperature Range	Reference Temp.
I	NPO	-55°C ~ +125°C	25 ℃
П	X7R	-55℃ ~ +125℃	25℃

5. Storage Condition

Storage Temperature : 5 to 40° C Relative Humidity : 20 to 70 % Storage Time : 12 months max.

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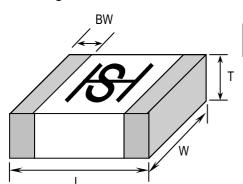
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Unit:mm



6. Dimensions

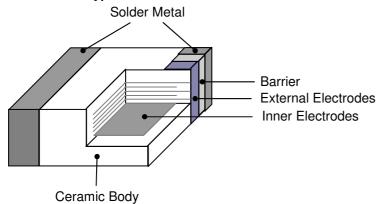
6.1 Configuration and Dimension:



 TYPE
 L
 W
 T
 BW (min)

 1812
 4.60±0.30
 3.20±0.30
 1.25±0.20
 0.20

6.2 Termination Type:



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7. Electronic Nominal Specification

7.1 Safety Standard:

TUV : IEC 60384-14:2013 EN 60384-14:2013 UL :UL 60384-14 CSA E60384-1 & CSA E60384-14

Temperature Characteristic	Class	Size	Rated Voltage	Certificated	-	Capacita 10 10	ince Range 1 10		03
NPO	X2	1808	250 Vrms	TUV/UL	2			1000	
X7R	X2	1808	250 Vrms	TUV/UL		150		2200	
X7R	X2	1812	250 Vrms	TUV/UL		3	30	4700	
X7R	X2	2220	250 Vrms	TUV/UL		150			33000
X7R	X2	2825	250 Vrms	UL			47	000	560
NPO	X1/Y2	1808	250 Vrms	TUV/UL	2		330		
X7R	X1/Y2	1808	250 Vrms	TUV/UL		150		1000	
NPO	X1/Y2	1812	250 Vrms	TUV/UL	2		680)	
X7R	X1/Y2	1812	250 Vrms	TUV/UL		130		1000	
NPO	X1/Y2	2208	250 Vrms	TUV/UL	2		330		
X7R	X1/Y2	2208	250 Vrms	TUV/UL		36		1000	
NPO	X1/Y2	2211	250 Vrms	TUV/UL	2			1000	
X7R	X1/Y2	2211	250 Vrms	TUV/UL		68		2700	
NPO	X1/Y2	2220	250 Vrms	TUV/UL	2			1200	
X7R	X1/Y2	2220	250 Vrms	TUV/UL		100		4700	
X7R	X2	2220	305 Vrms	TUV/UL		150			33000

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8. Performance

No.	Ite	m	Spe	cification	Test Condition		
1	Visı	ual	No abnormal exter	rior appearance	Visual Inspection		
2	Dimer	nsion	See Page 3 / Item		Visual Inspection		
3	Capac		Within the specifi	ed tolerance	Char. Frequency Voltage		
4	Q and Dissipation Factor		More than 30pF : Q ≥ 1000 30pF & below: Q≥ 400 + 20C (C:pF)		NPO		
				0.020)	After performing deage at 150±5% for 30min. and placement room temperature for 24±2hr.		
5	Insula		Minimum 10,000M	ΙΩ	Applied Voltage: Applied Voltage:500V Charge Time:60sec.		
6	Resistance Voltage Proof		breakdown		Applied Voltage: X Capacitor :Applied Voltage 1075Vdc(4.3Ur) Y Capacitor :Applied Voltage 1500Vac For 1min. Voltage ramp up rate ≤ 150V/sec(for Vac Test) charge/discharge Current is less than 50mA.		
7	7 Solderability		More than 90% of the terminal surface is to be soldered newly, so metal part does not come out or dissolve		Solder Temperature: 245±5°C Dip Time: 5 ± 0.5 sec. Immersing Speed: 25±10% mm/s Solder: Lead Free Solder Flux: Rosin Preheat: At 80~120 °C For 10~30sec.		
8	Resistance to	Appear- ance	No mechanical da	mage shall occur.	Bending shall be applied to the 1.0 mm with 1.0 mm/sec.		
	Flexure	Capacit-	Characteristic	Cap. Change			
	of Substrate	ance	Class I (NPO)	≤ ± 5.0% of initial value	The duration of the applied forces shall be 5 ± 1sec R340 Bending		
			Class II (X7R)	≤ ± 12.5% of initial value	Limit		
		Q / $\tan \delta$	To satisfy the spec		- I World		
		Insulation Resistance	To satisfy the spec	cified initial value	45±1mm 45±1mm Solder the capacitor on P.C. board shown in		
		Voltage Proof	To satisfy the spec	cified initial value	Fig 1. before testing.		
9	Robustness of		No indication of pethe terminal electron	eeling shall occur on ode.	Pull force shall be applied for 10± 1 second. ≤ 06035N(= 0.5 Kg·f)		
	Shear	Capacit-	Characteristic	Cap. Change	>060310N(=1.0 Kg·f)		
		ance	Class I (NPO)	$\leq \pm 5.0\%$ of initial			
			,	value	Ni.f		
			Class II (X7R)	\leq ± 12.5% of initial	N·f		
		0 / +00 %	To Cotiofy The Co	value	-		
		$Q / \tan \delta$		ecified Initial Value	Solder the capacitor on P.C. board shown in		
		Insulation Resistance	,	ecified Initial Value	Fig 1. before testing.		
		Voltage Proof		ecified Initial Value	i ig 1. belote testing.		

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No.	lte	em	Specification		Test Condition		
10	Resistance To	Appear- ance	No mechanical d	amage shall occur.	Class Class capacitor shall be set for 48±4 hours at room temperature after one hour heat		
		Capacit-	Characteristic	Cap. Change	treatment at 150 +0/-10°C before initial		
	Heat	ance	Class I (NPO)	≤ ± 10% of initial value	measure. Preheat : At 150± 10℃ For 60~120sec.		
			Class II (X7R)	≤ ± 20% of initial value	Dip : Solder Temperature of 260± 5°C Dip Time : 10 ± 1sec.		
		Q / Tan δ	To satisfy the spe	ecified initial value	Flux :Rosin Measure at room temp. after cooling for:		
		Insulation Resistance	More than 1,000	$M\Omega$	Class I : 24 ± 2 Hours Class II : 48 ± 4 Hours		
		Voltage Proof	To Satisfy The S	pecified Initial Value	OldSS II . 40 I 4 Flours		
11	Damp Heat /	Appear- ance	No mechanical d	amage shall occur.	Test Condition : Temperature : 40°C		
	Steady	Capacit-	Characteristic	Cap. Change	Humidity: 95 %RH		
	State	ance	Class I (NPO)	≤ ± 15% of initial	Test Time: 500hr (21days)		
			Class II (X7R)	value ≤ ± 15% of initial	The capacitors with rated voltage(250Vac) applied.		
			Olass II (X711)	value	Measure at room temp. after cooling for:		
		Q	More Than 30pF		Class I :24 ± 2 Hrs		
		Class I	30pF & Below:Q	≧ 275+2.5× C	Class II:48 ± 4 Hrs		
		Top 2	(C:pF)		Solder The Capacitor On P.C. Board Shown		
		Tan δ Class ${ m II}$	Maximum 5.0%		In Fig 2. Before Testing.		
		Insulation Resistance	More Than 1,000)M()			
		Voltage	To Satisfy The S	pecified Initial Value	-		
		Proof	10 00				
12	Endurance	Appear- ance	No Mechanical Occur	Damage Shall Be	Impulse Voltage Each individual capacitor shall be subjected		
		Capacit-	Characteristic	Cap. Change	to a 2.5KV(X2) and 5KV(X1/Y2) impulse for		
		ance	Class I (NPO)	≤ ± 20% of initial	three times. Then the capacitors are applied		
			Olara II (VZD)	value	to life test. (%) Front time $T_1=1.2\mu s=1.67T$		
			Class II (X7R)	≤ ± 20% of initial value	Time to half-value T ₂ =50µs		
		Q	More Than 30pF	II.	90		
		Class I	30pF & Below:Q				
		Tan δ	Maximum 5.0%		50		
		Class II	Minimum 1,000M	1	30 30		
		Insulation Resistance	INITITITITITI 1,000IV	177			
		Voltage	To satisfy the spe	ecified initial value	O T		
		Proof					
					Temperature : 125°C		
					Test Time: 1000hrs		
					Applied Voltage:		
					Class X Capacitors :1.25Ur (312.5Vac) Class Y Capacitors :1.70Ur (425Vac)		
					Except that once every hour the voltage		
					shall be increased to 1000Vrms for 0.1s.		

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SCC-TG-010-1810

No.	Item	Specification	Test Condition
13	Passive Flammability	Capacitor didn't burnt at all	Volume Sample : 21.56mm ³
		<u></u>	Flame exposure time : 5 sec.Max.
	Active		The capacitors of class each test capacitors
	Flammability	a flame	applied Ur(250Vac).
			Then each sample shall be subjected to 20 discharges from a tank capacitor, charge to a voltage that, when discharged, places Ui(2500V) across the capacitor under test. The interval between successive discharges shall be 5s.

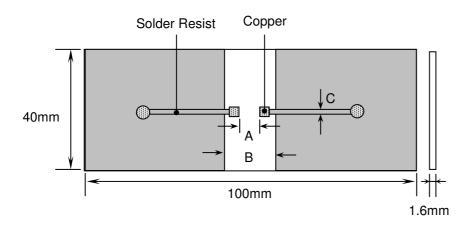
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Fig.1
P.C. Board for Bending Strength Test

(referring to IEC384-14 and EN132400)

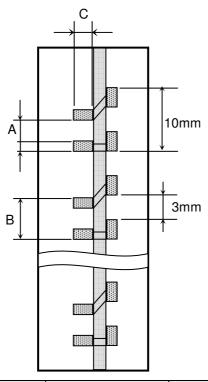


Material : Glass Epoxy Substrate

: Copper (Thickness : 0.035mm)

■: Solder Resist

Fig.2
Test Substrate



Material : Glass Epoxy Substrate

■ : Copper (Thickness : 0.035mm)

☐: Solder Resist
Thickness: 1.6 mm

Unit:mm

Туре	Α	В	С
1206	2.2	5.0	2.0
1808	3.5	7.0	2.5
1812	3.5	7.0	3.7
2208	4.5	8.0	2.5
2211	4.5	8.0	3.0
2220	4.5	8.0	5.6

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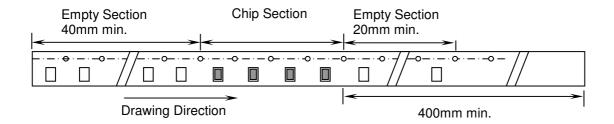


9. Packing

9.1 Bulk Packing

According to customer request.

9.2 Chip Capacitors Tape Packing



9.3 Material And Quantity

Tape	1206					
Material	T≦0.90mm	$0.90 \text{mm} < T \le 1.25 \text{mm}$	T>1.25mm			
Plastic	4,000 pcs/Reel	3,000 pcs/Reel	2,000 pcs/Reel			

Tape	18	08	1812/2208/2211/2220		
Material	$0.9 \text{mm} < T \le 1.25 \text{mm}$ $1.25 \text{mm} < T \le 2.0 \text{mm}$		1.25mm $<$ T \le 2.2mm \qquad T $>$ 2.2mm		
Plastic	3000 pcs/Reel	2000 pcs/Reel	1000 pcs/Reel	700 pcs/Reel	

Tape	2825
Material	T>2.6mm
Plastic	400 pcs/Reel

9.4 Cover Tape Reel Off Force

9.4.1 Peel-Off Force

5 g·f \leq Peel-Off Force \leq 70 g·f

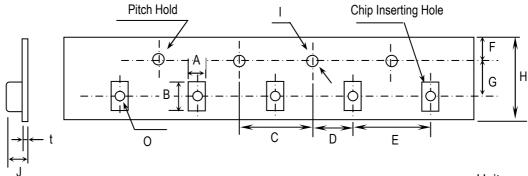
9.4.2 Measure Method



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9.5 Plastic Tape



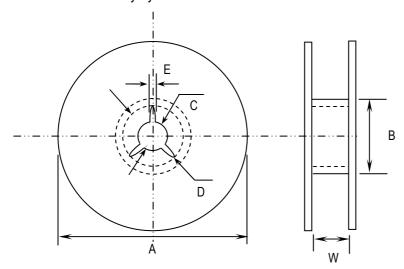
Unit:mm

Туре	Α	В	С	D	Е	F
1206	1.9± 0.2	3.5± 0.2	4.0± 0.1	2.0± 0.05	4.0± 0.1	1.75± 0.1
1808	2.5±0.2	4.9±0.2				
1812	3.6±0.2	4.9±0.2			8.0± 0.1	
2208	2.5±0.2	6.1±0.2				
2211	3.2±0.2	6.1±0.2				
2220	5.4±0.2	6.1±0.2				
2825	6.7±0.2	7.5±0.2			12.0± 0.1	

Туре	G	Н		J	t	0
1206	5.5± 0.05	12.0 ± 0.3	φ 1.5+0.1/-0	3.7 max.	0.3 max.	1.0± 0.1
1808						1.5± 0.1
1812						
2208						
2211						
2220						
2825	7.5± 0.10	16.0 ± 0.3			0.35 max.	

9.6 Reel Dimensions

Reel Material: Polystyrene



Unit:mm

Туре	Α	В	С	D	E	W
1206	178± 2.0	arphi 50 min	φ 13± 0.5	φ 21± 0.8	2.0±0.5	14± 0.15
1808						
1812						
2208						
2211						
2220						
2825						

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Caution

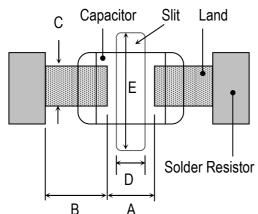
1. Storage

Store the capacitors where the temperature and relative humidity don't exceed 40° C and 70° RH. We recommend that the capacitors be used within 12 months from the date of manufacturing. Store the products in the original package and do not open the outer wrapped, polyethylene bag, till just before usage. If it is open, seal it as soon as possible or keep it in a desiccant with a desiccation agent.

2. Construction of Board Pattern

Improper circuit layout and pad/land size may cause excessive or not enough solder amount on the PC board. Not enough solder may create weak joint, and excessive solder may increase the potential of mechanical or thermal cracks on the ceramic capacitor. Therefore we recommend the land size to be as shown in the following table:

2.1 Size and recommend land dimensions for reflow soldering.



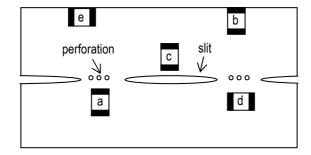
EIA Code	Chip (mm)		Land (mm)				
	Ш	W	Α	В	C	D	Е
1808	4.60	2.00	2.8~3.4	1.2~1.4	1.5~1.8	1.0~2.8	3.6~4.1
1812	4.60	3.20	2.8~3.4	1.2~1.4	2.3~3.0	1.0~2.8	4.8~5.3
2208	5.70	2.00	4.0~4.6	1.4~1.6	1.5~1.8	1.0~4.0	3.6~4.1
2211	5.70	2.80	4.0~4.6	1.4~1.6	2.0~2.6	1.0~4.0	4.4~4.9
2220	5.70	5.00	4.0~4.6	1.4~1.6	3.5~4.8	1.0~4.0	6.6~7.1

2.2 Mechanical strength varies according to location of chip capacitors on the P.C. board.

Design layout of components on the PC board such a way to minimize the stress imposed on the components, upon flexure of the boards in depanelization or other processes.

Component layout close to the edge of the board or the "depanelization line" is not recommended.

Susceptibility to stress is in the order of: a>b>c and d>e



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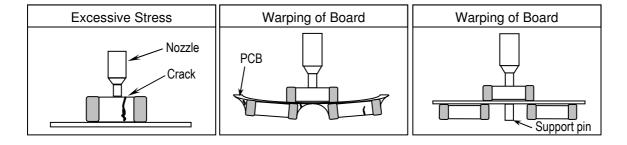
2.3 Layout Recommendation

Example	Use of Common Solder Land	Solder With Chassis	Use of Common Solder Land With Other SMD
Need to Avoid	Lead Wire Chip Solder Adhesive PCB Solder Land	Chassis Excessive Solder a	Solder Land
Recommendation	Chip Solder Resist Adhesive PCB Solder Land	Solder Resist $\alpha > \beta$	Solder Land

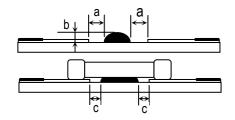
3. Mounting

3.1 Sometimes Crack is caused by the impact load due to suction nozzle in pick and place operation.

In pick and place operation, if the low dead point is too low, excessive stress is applied to component. This may cause cracks in the ceramic capacitor, therefore it is required to move low dead point of a suction nozzle to the higher level to minimize the board warp age and stress on the components. Nozzle pressure is typically adjusted to 1N to 3N (static load) during the pick and place operation.



3.2 Amount of Adhesive



Example: 0805 & 1206

а	0.2mm min.	
b	70 ~ 100 μm	
С	Do not touch the solder land	

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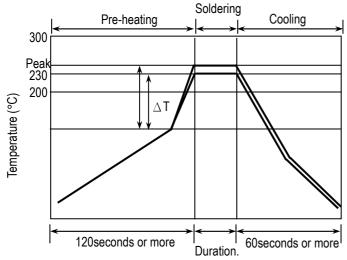


4. Soldering

4.1. Wave Soldering

Most of components are wave soldered with solder at Peak Temperature. Adequate care must be taken to prevent the potential of thermal cracks on the ceramic capacitors. Refer to the soldering methods below for optimum soldering benefits.

Recommend flow soldering temperature Profile



Soldering Method	Peak Temp.($^{\circ}$ C) / Duration (sec)
1206 and Under	ΔT ≤ 100~130 max.
Pb-Sn Solder	250°C (max.) / 3sec(max.)
Lead Free Solder	260°C (max.) / 5sec(max.)

Recommended solder compositions

Sn-37Pb (Pb - Sn Solder)

Sn-3.0Ag-0.5Cu (Lead Free Solder)

To optimize the result of soldering, proper preheating is essential:

- 1) Preheat temperature is too low
 - a. Flux flows to easily
 - b. Possibility of thermal cracks
- 2) Preheat temperature is too high
 - a. Flux deteriorates even when oxide film is removed
 - b. Causes warping of circuit board
 - c. Loss of reliability in chip and other components

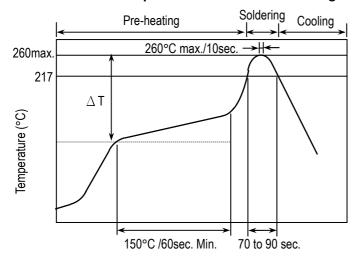
Cooling Condition:

Natural cooling using air is recommended. If the chips are dipped into a solvent for cleaning, the temperature difference (ΔT) between the solvent and the chips must be less than 100 °C.

4.2 Reflow Soldering

Preheat and gradual increase in temperature to the reflow temperature is recommended to decrease the potential of thermal crack on the components. The recommended heating rate depends on the size of component, however it should not exceed $3 \, \text{C/Sec}$.

Recommend reflow profile for Lead-Free soldering temperature Profile (MIL-STD-202G #210F)



* The cycles of soldering: Twice (max.)

Soldering Method	Change in Temp.($^{\circ}$ C)
1206 and Under	∆ T ≦ 190 °C
1210 and Over	∆ T ≦ 130 °C

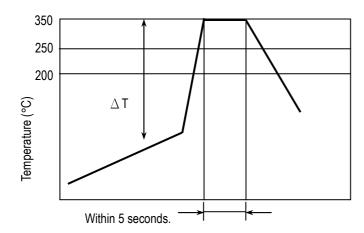
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4.3 Hand Soldering

Sudden heating of the components results in distortion due to a high internal temperature differential, causing cracked chips. When preheating, keep temperature differential Δ T, within the range shown in table. The smaller the Δ T, the less stress on the chip.



Soldering Method	Change in Temp.(°C)
1206 and Under	Δ T \leq 150 $^{\circ}$ C
1210 and Over	∆ T ≦ 130 °C

How to Solder Repair by Solder Iron

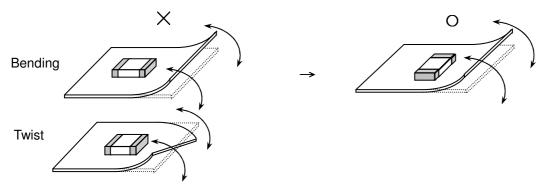
1) Selection of the soldering iron tip

Tip temperature of solder iron various by its type, P.C.board material and solder land size. Higher the tip temperature, quick the operation is .but the heat shock may crack the chip capacitor.

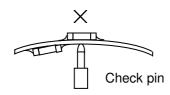
- 2) recommended solder iron condition
 - a.) Preheating Condition: Board and components should be preheated sufficiently at 150 ℃ or over, and soldering should be conducted with soldering iron as boards and components are maintained at sufficient temperatures.
 - b.) Soldering iron power shall not exceed 30 W.
 - c.) Soldering iron tip diameter shall not exceed 3mm.
 - d.) Temperature of iron tip shall not exceed 350° C and the process should be finished within 5 seconds. (refer to MIL-STD-202G)
 - e.) Do not touch the ceramic dielectric with solder iron other than the terminations. Direct contact of the soldering iron with ceramic dielectric of chip capacitor may cause crack.
 - f.) After soldering ,let the products to cool down gradually in the room temperature.
- * The soldering to lose the use of electronic heat gun.

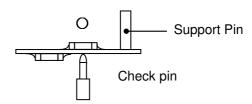
5. Handling after chip mounted

5.1 Please pay attention put the component lateral to the direction in which stress acts.



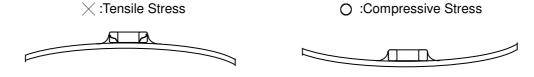
5.2 Crack will be caused if board is warped due to excessive load by check pin.



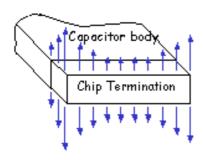


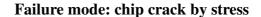


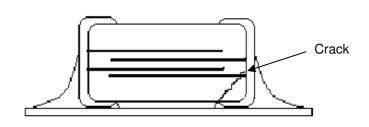
- 5.3 Mechanical stress due to warping and torsion by dividing.
 - (a) Crack occurrence ratio will be increased by manual separation.
 - (b) Crack occurrence ratio will be increased by tensile force , rather than compressive force.



Capacitor Stress Analysis

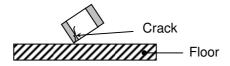




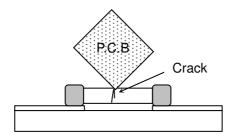


6. Handling of Loose Chip Capacitor

6.1 If dropped the chip capacitor may crack.



6.2 Piling the P.C. board after mounting for storage or handling, the corner of the P.C. board may hit the chip capacitor of another of board to cause crack.



7. Safekeeping condition and period

For safekeeping of the products, we recommend to keep storage temperature +5 ~+40°C , Humidity 20 ~70%RH and use them within 12 months.

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